



Product Change Notification - GBNG-11UHCQ675

Date:

15 Aug 2019

Product Category:

Others

Affected CPNs:**Notification subject:**

CCB 3754 Final Notice: Qualification of MMT as a new assembly site for selected SMSC COM2002013V device family available in 28L PLCC (11.5x11.5x4.4mm) package.

Notification text:**PCN Status:**

Final notification

PCN Type:

Manufacturing Change

Microchip Parts Affected:

Please open one of the icons found in the Affected CPNs section above.

NOTE: For your convenience Microchip includes identical files in two formats (.pdf and .xls).

Description of Change:

Qualification of MMT as a new assembly site for selected SMSC COM2002013V device family available in 28L PLCC (11.5x11.5x4.4mm) package.

Pre Change:

Assembled at OSE using 1076WA die attach, G631 mold compound and A151 lead frame material with MSL 3 classification.

Post Change:

Assembled at MMT using 3280 die attach, G600V mold compound and A194 lead frame material with MSL 1 classification.

Pre and Post Change Summary:

	Pre Change	Post Change
Assembly Site	Orient Semiconductor Electronics, Ltd (OSE)	Microchip Technology Thailand (Branch) (MMT)
Wire material	Au	Au
Die attach material	1076WA	3280
Molding compound material	G631	G600V
Lead frame material	A151	A194
MSL Classification	MSL3/260C	MSL1/245C

Impacts to Data Sheet:

None

Change Impact:

None

Reason for Change:

To improve on-time delivery performance by qualifying MMT as a new assembly site.

Change Implementation Status:

In Progress

Estimated First Ship Date:

September 15, 2019 (date code: 1938)

NOTE: Please be advised that after the estimated first ship date customers may receive pre and post change parts.



Time Table Summary:

Workweek	March 2019					->	August 2019					September 2019			
	09	10	11	12	13		31	32	33	34	35	36	37	38	39
Initial PCN Issue Date				X											
Qual Report Availability									X						
Final PCN Issue Date									X						
Estimated Implementation Date													X		

Method to Identify Change:

Traceability code

Qualification Report:

Please open the attachments included with this PCN labeled as PCN_#_Qual Plan.

Revision History:

March 19, 2019: Issued initial notification.

August 15, 2019: Issued final notification. Attached the qualification report. Provided estimated first ship date to be on September 15, 2019.

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products.

Attachment(s):

[PCN_GBNG-11UHCQ675 Qual Report.pdf](#)

Please contact your local [Microchip sales office](#) with questions or concerns regarding this notification.

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QUALIFICATION REPORT SUMMARY
RELIABILITY LABORATORY

PCN #: GBNG-11UHCQ675

Date
July 30, 2019

**Qualification of MMT as a new assembly site for selected
SMSC COM20020I3V device family available in 28L PLCC
(11.5x11.5x4.4mm) package.**



MICROCHIP PACKAGE QUALIFICATION REPORT

Purpose	Qualification of MMT as a new assembly site for selected SMSC COM20020I3V device family available in 28L PLCC (11.5x11.5x4.4mm) package.
CCB No.	3754
CN	ES289266
QUAL ID	Q19052 Rev. A
MP CODE	UA0037L4XA00
Part No.	COM20020I3V-DZD
Bonding No.	BDM-002088 Rev. A
<u>Package</u>	
Type	28L PLCC
Die thickness	15 mils
Die size	103.5 x 102.5 mils
<u>Lead Frame</u>	
Paddle size	200 x 200 mils
Material	A194
Surface	Ag ring plated
Process	Stamped
Lead Lock	No
Part Number	10102832
Treatment	None
<u>Material</u>	
Epoxy	3280
Wire	Au wire
Mold Compound	G600V
Plating Composition	Matte Tin



MICROCHIP PACKAGE QUALIFICATION REPORT

Manufacturing Information

Assembly Lot No.	Wafer Lot No.	Date Code
MMT-195001630.000	TC10919405478.300	1911J68
MMT-195001962.000	TC10919405478.300	1911R2A
MMT-195001963.000	TC10919405478.300	1911R69

Result Pass Fail _____

28L PLCC assembled by MMT pass reliability test per QCI-39000. This package was qualified the Moisture/Reflow Sensitivity Classification Level 1 at 245°C reflow temperature per IPC/JEDEC J-STD-020E standard.

PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard / Method	Qty. (Acc.)	Def/SS	Result	Remarks
Moisture/Reflow Sensitivity Classification Test (At MSL Level 1)	85°C/ 85%RH Moisture Soak 168 hrs. System: TABAI ESPEC Model PR-3SPH 3x Convection-Reflow 250°C max System: Vitronics Soltec MR1243 (IPC/JEDEC J-STD-020E)	IPC/JEDEC C J-STD-020E	135	0/135	Pass	

<u>Precondition</u> <u>Prior Perform</u> <u>Reliability Tests</u> (At MSL Level 1)	Electrical Test :+25°C and 110°C System: LTX_D10	JESD22- A113	693(0)	693		Good Devices
	Bake 150°C, 24 hrs System: CHINEE			693		
	85°C/85%RH Moisture Soak 168 hrs. System: TABAI ESPEC Model PR-3SPH			693		
	3x Convection-Reflow 250°C max System: Vitronics Soltec MR1243			693		
	Electrical Test :+25°C and 110°C System: LTX_D10			0/693	Pass	

PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
Temp Cycle	Stress Condition: -65°C to +150°C, 500 Cycles System : TABAI ESPEC TSA-70H	JESD22-A104		231		Parts had been pre-conditioned at 245°C
	Electrical Test: +110°C System: LTX_D10		231(0)	0/231	Pass	77 units / lot
	Bond Strength: Wire Pull (> 2.5 grams) Bond Shear (>15.00 grams)		15 (0)	0/15	Pass	
UNBIASED-HAST	Stress Condition: +130°C/85%RH, 96 hrs. System: HAST 6000X	JESD22-A118		231		Parts had been pre-conditioned at 245°C
	Electrical Test: +25°C System: LTX_D10		231(0)	0/231	Pass	77 units / lot
HAST	Stress Condition: +130°C/85%RH, 96 hrs. Bias Volt: 3.3 Volts System: HAST 6000X	JESD22-A110		231		Parts had been pre-conditioned at 245°C
	Electrical Test: +25°C and 110°C System: LTX_D10		231(0)	0/231	Pass	77 units / lot

PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
High Temperature Storage Life	Stress Condition: Bake 175°C, 504 hrs System: SHEL LAB	JESD22- A103		45		45 units
	Electrical Test :+25°C and 110°C System: LTX_D10		45(0)	0/45	Pass	
Physical Dimensions	Physical Dimension, 10 units from 1 lot	JESD22- B100/B108	30(0) Units	0/30	Pass	
Bond Strength Data Assembly	Wire Pull (> 2.5 grams)	M2011	30 (0) Wires	0/30	Pass	
	Bond Shear (>15.00 grams)	JESD22- B116	30 (0) bonds	0/30	Pass	

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Affected Catalog Part Numbers(CPN)

COM20020I3V-DZD

COM20020I3V-DZD-TR